MM2758 8,192-Bit (1024 × 8) UV Erasable PROM

General Description

The MM2758 is a high speed 8k UV erasable and electrically reprogrammable EPROM, ideally suited for applications where fast turnaround and pattern experimentation are important requirements.

The MM2758 is packaged in a 24-pin dual-in-line package with transparent lid. The transparent lid allows the user to expose the chip to ultraviolet light to erase the bit pattern. A new pattern can then be written into the device by following the programming procedure.

This EPROM is fabricated with the reliable, high volume, time proven, N-channel MOS silicon gate technology.

Features

- Access time-450 ns
- Low power consumption
 Active power: 525 mW max
 Standby power: 132 mW max (75% savings)
- Single 5V power supply
- Pin compatible to National's higher density EPROMs

DATA OUTPUTS

- Static—no clocks required
- TTL compatible inputs/outputs
- TRI-STATE® output

Block and Connection Diagrams

Pin Names

A0-A14	Addresses
CE	Chip Enable
ŌĒ	Output Enable
00-07	Outputs
PGM	Program
NC	No Connect
*A _R	Select Reference Input Level

Vcc 0	•		00-07
GND O			1111111
Œ → CE/PGM →	OUTPUT ENABLE CHIP ENABLE AND PROG LOGIC]=[OUTPUT Buffers
	Y Decoder		Y GATING
Ag-Ag ADDRESS INPUTS AR	X DECODER		8192-BHT CELL MATRIX
			TL/D/5475-1

27C32

27C64

27C128

27C256

27C256 27256	27C128 27128	27C64 2764	27C32 2732	27C16 2716
Vpp	Vpp	Vpp		
A12	A12	A12		
A 7	A7	A 7	A 7	A7
A6	A6	A6	A6	A6
A 5	A5	A5	A5	A 5
A4	A4	A4	A4	A4
A3	A3	A3	A3	EA.
A2	A2	A2	A2	A2
A1	A1	A1	A1	A1
A0	A0	AO	AO	AO
00	00	Da	D ₀	00
01	01	01	01	01
02	02	02	02	02

					Vcc	Vcc	Vcc	
D	Pual-in-Line Pack	age			PGM	PGM	A14	
A7	1	24 VCC	Vcc	Vcc	NC	A13	A13	
A6	2	23 — A8	A8	A8	A8	AB	A8	
A5	3	22 A9	A9	A9	A9	A9	A9	
A4 —	4	21 — Vpp	Vpp	A11	A11	A11	A11	
A3	5	20 ŌĒ	ŌĒ	OE/Vpp	ŌĒ	ŌĒ	ŌĒ	
A2	MINIT LOG	19 An*	A10	A10	A10	A10	A10	
A1	7 TOP VIEW	18 — ČĒ	CE	CE	ĈĒ	CE	Œ	
A0	8	17 07	07	07	07	07	07	
00	9	16 06	06	06	06	06	06	
01 —	10	15 - 05	05	05	05	05	05	
O2	11	14 04	04	D4	04	04	04	
GND -	12	13 03	03	D ₃	03	03	03	

27C16

Note: National's socket compatible EPROM pin configurations are shown in the blocks adjacent to the MM2755 pins.

* For MM2758A, $A_R = V_{IL}$ for all operating modes.

For MM2758B, $A_{\text{R}} = V_{\text{IH}}$ for all operating modes.

Order Number MM2758Q-A or MM2758Q-B NS Package Number J24A-Q TL/D/5475-2

6-10

Absolute Maximum Ratings (Note 1) Operating Conditions (Note 9)

Temperature Under Bias -10°C to +80°C Storage Temperature -65°C to +125°C

All Input or Output Voltages with
Respect to Ground + 6.5V to - 0.3V

V_{PP} Supply Voltage with Respect

READ OPERATION

to Ground During Program + 26.5V to - 0.3V
Power Dissipation 1.5W

Lead Temperature (Soldering, 10 seconds)

Temperature Range 0°C-70°C V_{CC} Power Supply (Notes 2 and 3) $5V \pm 5\%$ V_{PP} Power Supply (Note 3) V_{CC}

DC and Operating Characteristics

Symbol	Parameter	Conditions	Min	Typ (Note 4)	Max	Units
l _{Li}	Input Load Current	V _{IN} = V _{CC} or GND			10	μΑ
ILO	Output Leakage Current	V _{OUT} = V _{CC} or GND, \overrightarrow{CE} = V _{IH}			10	μΑ
I _{CC1}	V _{CC} Current (Standby)	CE = V _{IH}		10	25	mA
I _{CC2} (Note 3)	V _{CC} Current (Active)	OE = CE = V _{IL} , I/O = 0 mA	Ī	57	100	mA
V _{IL}	Input Low Voltage		- 0.1		0.8	٧
VIH	Input High Voltage		2.0		V _{CC} +1	٧
V _{OL}	Output Low Voltage	I _{OL} = 2.1 mA			0.45	٧
V _{OH}	Output High Voltage	I _{OH} = - 400 μA	2.4			v

300°C

AC Characteristics

Symbol	Parameter	Conditions	Min	Max	Units
t _{ACC}	Address to Output Delay	CE = OE = VIL		450	ns
t _{CE}	CE to Output Delay	OE = V _{IL}		450	ns
toE	Output Enable to Output Delay	CE = V _{IL}		120	ns
t _{DF}	Output Enable High to Output Float	CE = V _{IL}	0	100	ns
t _{OH} (Note 5)	Output Hold from Addresses, CE or OE, Whichever Occurred First	CE = OE = V _{IL}	0		ns

Capacitance (Note 5) (T_A = +25°C, f = 1 MHz)

Symbol	Parameter	Conditions	Тур	Max	Units
CIN	Input Capacitance	V _{IN} = 0V	4	6	рF
Cout	Output Capacitance	V _{OUT} = 0V	8	12	pF

AC Test Conditions

Output Load 1 TTL Gate and C_L = 100 pF Input Rise and Fall Times ≤ 20 ns

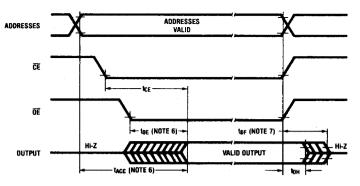
Input Pulse Levels 0.8V to 2.2V

Timing Measurement Reference Level

 Inputs
 1V and 2V

 Outputs
 0.8V and 2V

AC Waveforms (Note 2)

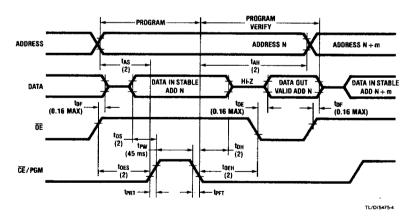


TL/D/5475-3

Note 1: Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

- Note 2: VCC must be applied simultaneously or before Vpp and removed simultaneously or after Vpp.
- Note 3: Vpp may be connected to VCC except during programming. ICC2≤ the sum of the ICC active and Ipp read currents.
- Note 4: Typical values are for $T_{\Delta} = +25^{\circ}$ C and nominal supply voltages.
- Note 5: This parameter is only sampled and is not 100% tested.
- Note 6: OE may be delayed up to tACC tOF after the falling edge of CE without impact on tACC.
- Note 7: The tDF compare level is determined as follows:
- High to TRI-STATE, the measured VOH (DC) 0.10V
- Low to TRI-STATE, the measured VOL (DC) + 0.10V
- Note 8: TRI-STATE may be attained using OE or CE.
- Note 9: The power switching characteristics of EPROMs require careful device decoupling. It is recommended that a 0.1 µF ceramic capacitor be used on every device between V_{CC} and GND.

Programming Waveforms (Note 3) (VPP = 25V ± 1V, VCC = 5V ± 5%)



Note: All times shown in parentheses are minimum times and are in µs unless otherwise specified.

Note 1: National's standard product warranty applies only to devices programmed to specifications described herein.

Note 2: V_{CC} must be applied simultaneously or before V_{PP} and removed simultaneously or after V_{PP}. The MM2758 must not be inserted into or removed from a board with V_{PP} at 25V ± 1V to prevent damage to the device.

Note 3: The maximum allowable voltage which may be applied to the Vpp pin during programming is 26V. Care must be taken when switching the Vpp supply to prevent overshoot exceeding this 26V maximum specification. A 0.1 µF capacitor is required across Vpp, V_{CC} to GND to suppress spurious voltage transients which may damage the device.

PROGRAMMING CHARACTERISTICS (Note 1)

DC Programming Characteristics (Notes 2 and 3) ($T_A = +25$ °C \pm 5°C, $V_{CC} = 5V \pm 5\%$, $V_{PP} = 25V \pm 1V$)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
l _u	Input Current (for Any Input)	V _{IN} = V _{CC} or GND			10	μΑ
Грр	V _{PP} Supply Current During Programming Pulse	CE/PGM = V _{IH}			30	mA
Icc	V _{CC} Supply Current				100	mA
V _{IL}	Input Low Level		- 0.1		0.8	٧
V _{IH}	Input High Level		2.0		V _{CC} + 1	٧

AC Programming Characteristics (Notes 2 and 3) ($T_A = +25$ °C ± 5 °C, $V_{CC} = 5V \pm 5\%$, $V_{PP} = 25V \pm 1V$)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
t _{AS}	Address Set-Up Time		2			μS
toes	OE Set-Up Time		2			μS
t _{DS}	Data Set-Up Time		2			μS
t _{AH}	Address Hold Time		2			μS
toeh	ÖE Hold Time		2			μS
t _{DH}	Data Hold Time		2			μS
t _{DF}	Output Enable to Output Float Delay	$\overline{CE}/PGM = V_{1L}$	0		160	ns
toE	Output Enable to Output Delay	CE/PGM = V _{IL}			160	ns
t _{PW}	Program Pulse Width		45	50	55	ms
t _{PRT}	Program Pulse Rise Time		5			ns
t _{PFT}	Program Pulse Fall Time		5			ns

AC Test Conditions

 V_{CC} 5V ± 5% V_{PP} 25V ± 1V Input Rise and Fall Times ≤ 20 ns Input Pulse Leveis 0.8V to 2.2V

Timing Measurement Reference Level

Inputs 1V and 2V Outputs 0.8V and 2V

Functional Description

DEVICE OPERATION

The five modes of operation of the MM2758 are listed in Table I. It should be noted that all inputs for the five modes are at TTL levels. The power supplies required are a 5V V_{CC} and a V_{PP} . The V_{PP} power supply must be at 25V during the three programming modes, and must be at 5V in the other two modes.

Read Mode

The MM2758 has two control functions, both of which must be logically active in order to obtain data at the outputs. Chip Enable ($\overline{\text{CE}}$) is the power control and should be used for device selection. Output Enable ($\overline{\text{CE}}$) is the output control and should be used to gate data to the output pins, independent of device selection. Assuming that addresses are stable, address access time (t_{ACC}) is equal to the delay from $\overline{\text{CE}}$ to output (t_{CE}). Data is available at the outputs togafter the falling edge of $\overline{\text{OE}}$, assuming that $\overline{\text{CE}}$ has been low and addresses have been stable for at least t_{ACC} -tog.

Standby Mode

The MM2758 has a standby mode which reduces the active power dissipation by 75%, from 525 mW to 132 mW. The MM2758 is placed in the standby mode by applying a TTL high signal to the $\overline{\text{CE}}$ input. When in standby mode, the outputs are in a high impedance state, independent of the $\overline{\text{OE}}$ input.

Output OR-Tying

Because MM2758s are usually used in larger memory arrays, National has provided a 2-line control function that accommodates this use of multiple memory connections. The 2-line control function allows for:

- a) the lowest possible memory power dissipation, and
- complete assurance that output bus contention will not occur.

To most efficiently use these two control lines, it is recommended that \overline{CE} (pin 18) be decoded and used as the primary device selecting function, while \overline{OE} (pin 20) be made a common connection to all devices in the array and connected to the READ line from the system control bus. This assures that all deselected memory devices are in their low power standby modes and that the output pins are active only when data is desired from a particular memory device.

Programming

CAUTION: Exceeding 26.5V on pin 21 (V_{PP}) will damage the MM2758.

Initially, and after each erasure, all bits of the MM2758 are in the "1" state. Data is introduced by selectively programming "0s" into the desired bit locations. Although only "0s" will be programmed, both "1s" and "0s" can be presented in the data word. The only way to change a "0" to a "1" is by ultraviolet light erasure.

The MM2758 is in the programming mode when the V_{PP} power supply is at 25V and \overline{OE} is at V_{IH} . It is required that a 0.1 μ F capacitor be placed across V_{PP} , V_{CC} to ground to suppress spurious voltage transients which may damage the device. The data to be programmed is applied 8 bits in parallel to the data output pins. The levels required for the address and data inputs are TTL.

When the address and data are stable, a 50 ms, active high, TTL program pulse is applied to the $\overline{\text{CE}}/\text{PGM}$ input. A program pulse must be applied at each address location to be programmed. You can program any location at any time—either individually, sequentially, or at random. The program pulse has a maximum width of 55 ms. The MM2758 must not be programmed with a DC signal applied to the $\overline{\text{CE}}/\text{PGM}$ input.

Programming of multiple MM2758s in parallel with the same data can be easily accomplished due to the simplicity of the programming requirements. Like inputs of the paralleled MM2758s may be connected together when they are programmed with the same data. A high level TTL pulse applied to the $\overline{\text{CE}}/\text{PGM}$ input programs the paralleled MM2758s.

Program Inhibit

Programming multiple MM2758s in parallel with different data is also easily accomplished. Except for $\overline{\text{CE}}/\text{PGM}$, all like inputs (including $\overline{\text{OE}}$) of the parallel MM2758s may be common. ATTL level program pulse applied to an MM2758's $\overline{\text{CE}}/\text{PGM}$ input with V_{PP} at 25V will program that MM2758. A low level $\overline{\text{CE}}/\text{PGM}$ input inhibits the other MM2758 from being programmed.

Program Verify

A verify should be performed on the programmed bits to determine whether they were correctly programmed. The verify may be performed with V_{PP} at 25V. Except during programming and program verify, V_{PP} must be at V_{CC} .

TABLE I. Mode Selection

Pins	CE/PGM	ŌĒ	Vpp	Vcc	Outputs
Mode	(18)	(20)	(21)	(24)	(9-11, 13-17)
Read	V _{IL}	V _{IL}	Vcc	5	D _{OUT}
Standby	V _{IH}	Don't Care	V _{CC}	5	Hi-Z
Program	Pulsed VIL to VIH	V _{IH}	25	5	DIN
Program Verify	V _{IL}	VIL	25	5	D _{OUT}
Program Inhibit	V _{IL}	V _{IH}	25	5	Hi-Z

Functional Description (Continued)

FRASHIRE CHARACTERISTICS

The erasure characteristics of the MM2758 are such that erasure begins to occur when exposed to light with wavelengths shorter than approximately 4000 Angstroms (Å). It should be noted that sunlight and certain types of fluorescent lamps have wavelengths in the 3000 Å-4000 Å range. Data shows that constant exposure to room-level fluorescent lighting could erase the typical MM2758 in approximately 3 years, while it would take approximately 1 week to cause erasure when exposed to direct sunlight. If the MM2758 is to be exposed to these types of lighting conditions for extended periods of time, opaque labels should be placed over the MM2758 window to prevent unintentional erasure. Covering the window will also prevent temporary functional failure due to the generation of photo currents.

The recommended erasure procedure for the MM2758 is exposure to short wave ultraviolet light which has a wavelength of 2537 Angstroms (Å). The integrated dose (i.e., UV intensity x exposure time) for erasure should be a minimum of 15W-sec/cm². The erasure time with this dosage is approximately 21 minutes using an ultraviolet lamp with a 12,000 $\,\mu\text{W/cm}^2$ power rating. The MM2758 should be placed within 1 inch of the lamp tubes during erasure. Some lamps have a filter on their tubes which should be removed before erasure.

Note: The MM2758 may take up to 60 minutes for complete erasure to occur.

An erasure system should be calibrated periodically. The distance from lamp to unit should be maintained at one

inch. The erasure time increases as the square of the distance. (If distance is doubled the erasure time increases by a factor of 4.) Lamps lose intensity as they age. When a lamp is changed, the distance has changed or the lamp has aged, the system should be checked to make certain full erasure is occurring. Incomplete erasure will cause symptoms that can be misleading. Programmers, components, and even system designs have been erroneously suspected when incomplete erasure was the problem.

SYSTEM CONSIDERATION

The power switching characteristics of EPROMs require careful decoupling of the devices. The supply current, ICC, has three segments that are of interest to the system designer-the standby current level, the active current level, and the transient current peaks that are produced on the falling and rising edges of chip enable. The magnitude of these transient current peaks is dependent on the output capacitance loading of the device. The associated transient voltage peaks can be suppressed by properly selected decoupling capacitors. It is recommended that a 0.1 µF ceramic capacitor be used on every device between V_{CC} and GND. This should be a high frequency capacitor of low inherent inductance. In addition, a 4.7 µF bulk electrolytic capacitor should be used between V_{CC} and GND for each eight devices. The bulk capacitor should be located near where the power supply is connected to the array. The purpose of the bulk capacitor is to overcome the voltage droop caused by the inductive effects of the PC board traces.